

**Notice of References Cited**Application/Control No.  
**10/046,480**Applicant(s)/Patent Under Reexam  
**Shiraiwa**Examiner  
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**2622**

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**U.S. PATENT DOCUMENTS**

	Document Number Country Code-Number-Kind Code	Date MM-YYYY <sup>1</sup>	Name	Classification <sup>2</sup>	
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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